## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10647159	LOVE ET AL.

Examiner Art Unit

Keefer, Michael E 2154

## **SEARCHED**

Class	Subclass	Date	Examiner
709	202 (updated 1/14/2008)	12/26/2006	MEK
709	224	2/14/2007	MEK
719	314	2/14/2007	MEK

## **SEARCH NOTES**

Search Notes	Date	Examiner
EAST Search	12/18/2006	MEK
EAST Search	4/26/2007	MEK
EAST Search	10/18/2007	MEK
Consulted Examiner Dustin Nguyen	10/18/2007	MEK
Consulted Examiner Hassan Phillips	2/11/2008	MEK
Consulted Primary Examiner Dustin Nguyen	2/11/2008	MEK
Consulted SPE Nathan Flynn	2/14/2008	MEK

## **INTERFERENCE SEARCH**

Class	Subclass	Date	Examiner
709	202, 224	2/14/2008	MEK
719	314	2/14/2008	MEK

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